Near Infrared Spectrometer







SM304

Near-Infrared (NIR) Spectrometer

User Selectable various NIR Range from 0.9 - 2.5 μm

Low Dark Noise and High Stability

Best Performance for NIR Spectroscopy

Wide dynamic range and high signal to noise ratio

Optical Dark Option (Auto Shutter)

The Choice for Low Signal Level NIR Applications

Spectral Products is offering the new SM304 TE cooled InGaAs / Extended-InGaAs array spectrometers. The SM304 series are ideal for NIR spectroscopic measurement that requires very high signal to noise ratio and/or high dynamic rang through 0.9 - 2.5 µm spectral range.

SPECTRAL PRODUCTS

The high performance with low-noise level of the SM304 series makes it possible to apply in very demanding applications. The good sensitivity of the detectors used in the SM304 series allows various broad-band applications like, measuring optical properties of solid/liquid/gas samples in NIR range, analyzing chemical components and detection of moisture, as well as a narrow band applications like NIR laser characterization.

Standard interface of the SM304 series is a USB 1.1/2.0 compatible interface with 16-bit AD conversion. Software support includes an SDK and DLLs for dedicated applications development and Windows OS-based spectral acquisition and analysis software(SM32ProMX).

Spectrometer SM304

Specifications:

Feature	Value							
Models	SM304-512	SM304-512-2.2	SM304-512-2.5	SM304-256-2.1	SM304-256-2.5			
Detectors	G9204-512	G9206-512	G9208-512	G9206-256	G9208-256			
Pixel Size	25 X 500 μm	25 X 250 μm		50 X 500 μm				
Spectrograph f-number	3.3							
Dark	Auto Shutter							
Dark Readout Noise RMS*	10 @1	100ms 20 @10ms		10 @100ms	12 @10ms			
Signal to Noise Ratio (SNR)	>15,000 : 1 @100 ms		>10,000 : 1 @ 100 ms		>7,500 : 1 @ 10 ms			
Spectral Response Range	0.9-1.7 μm	0.9-2.2 μm	0.9-2.5 μm	0.9-2.0 5µm	0.9-2.5 μm			
Order Sorting Filter	Longpass filter or linear variable filter installed according to wavelength coverage							
Optical Resolution (Max. with 25 um or 50 um slit)	>3 nm overall	>4.5 nm overall	>5.5 nm overall	>7.0 nm overall	>9.0 nm overall			
Stray Light	<0.1 % at 1550 nm							
Fiber Coupling	SMA905 or FC/PC standard							
Computer interface	USB 1.1/2.0 compatible							
Minimum integration time	1 msec							
Trigger Mode	Free Run Mode							
	Software Trigger Mode							
	External trigger mode (20-pin connector): TTL Edge trigger input							
Dimensions	6.81 X 4.72 X 2.95 inches (173 X 120 X 75 mm)							
Weight	4.4lbs (2.0 kg)							
Software	SM32ProMX							
	Includes DLL libraries and SDKs for user customized application development							

*: Measured with TEC On & 10pF CF value

Resolution Chart:

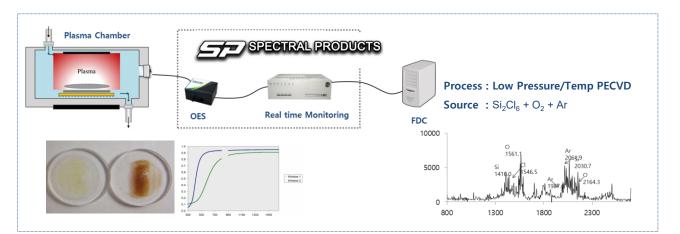
Feature	Value						
Models	SM304-512	SM304-512-2.2	SM304-512-2.5	SM304-256-2.1	SM304-256-2.5		
Spectral Response Range	0.9-1.7 μm	0.9-2.2 μm	0.9-2.5 μm	0.9-2.05 μm	0.9-2. 5µm		
Slit Width (µm)	Max. Optical Resolution (FWHM, nm)						
25	3	4.5	5.5	-	9		
50	-	-	-	7	12		

Note) Optical Resolution Value : Average

Applications

NIR OES Sensor for Plasma Diagnostics

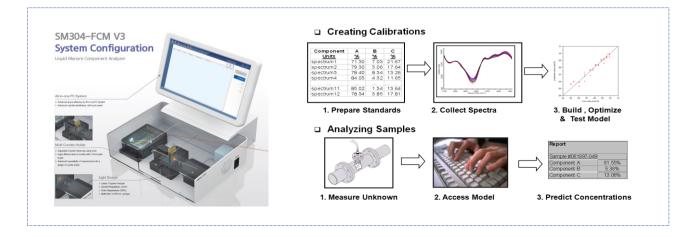
- Long term usage resistant to view port pollution for plasma diagnostics in semiconductor fabrications
- Extended spectral range of OES(optical emission spectroscopy) sensor up to 2.5 μm



Real time NIR Spectrophotometer

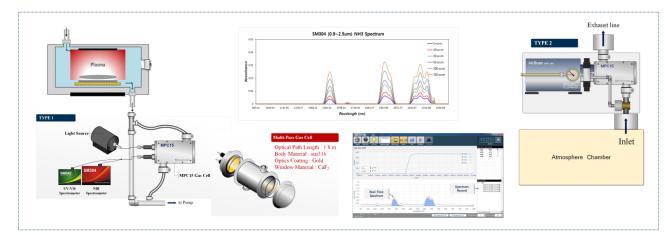
SPECTRAL PRODUCTS

- Real time measurement of transmission and absorption without mechanical grating rotation / scanning
- Analysis and optical monitoring of various solid / liquid / gas samples (Chemicals, Liquid Fertilizer, etc.)
- Customized calibration formula by use of signal processing, chemo-metrics and statistical algorithms



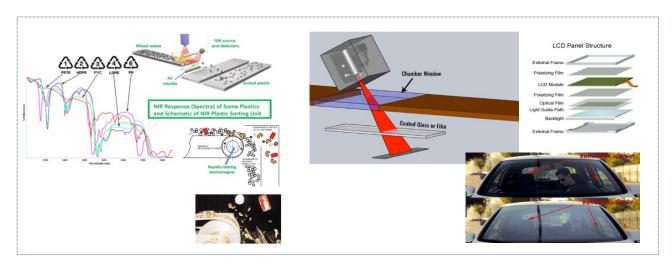
Optical Monitoring of Gas and Water Vapor

- In-Situ quantitative optical monitoring of vacuum / atmospheric gases and water vapor
- Customized configuration for various applications in laboratories and industrial factories

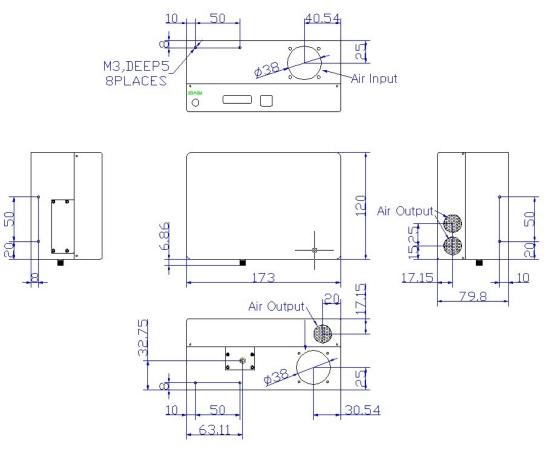


Analysis of optical & chemical properties of films and materials

- Measurement of thickness and optical properties of high thickness films
- Measurement of reflectance and transmittance (absorbance) of various materials (plastic, film, etc.)



Case Dimension:



Units in mm

Ordering Information : Please indicate product number and description when ordering

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SPECTRAL PRODUCTS